


<b>Search Notes</b> 	<b>Application/Control No.</b> 10553911	<b>Applicant(s)/Patent Under Reexamination</b> EYER ET AL.
	<b>Examiner</b> SUSAN HANLEY	<b>Art Unit</b> 1651

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
WEST: USPAT, EPAB, JPAB, PGPUBS, USOCR, DWPI, see attached	4/21/08	SMH
INVNETOR SEARCH: PALM, WEST	4/21/08	SMH
WEST: USPAT, EPAB, JPAB, PGPUBS, USOCR, DWPI, see attached	4/23/08	SMH
STN: REG, CAPLUS see attached	4/21/08	SMH

INTERFERENCE SEARCH			
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